



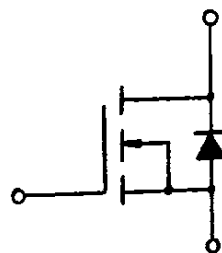
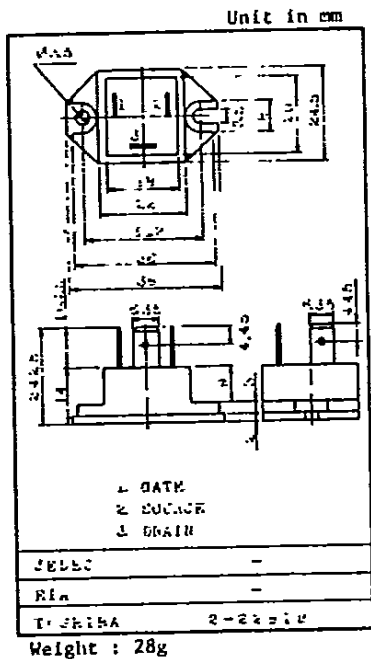
SEMICONDUCTOR TECHNICAL DATA

MG15G1AM1
MG15G4GM1 (450V/15A)
MG15G6EM1

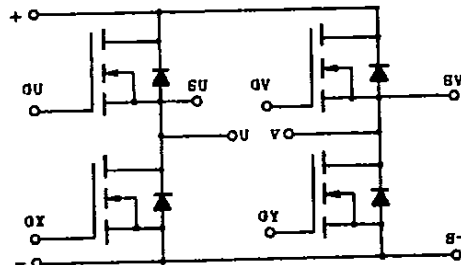
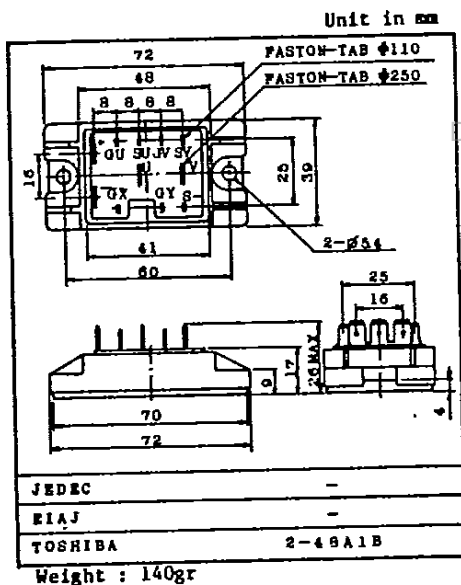
EQUIVALENT CIRCUIT

OUTLINE

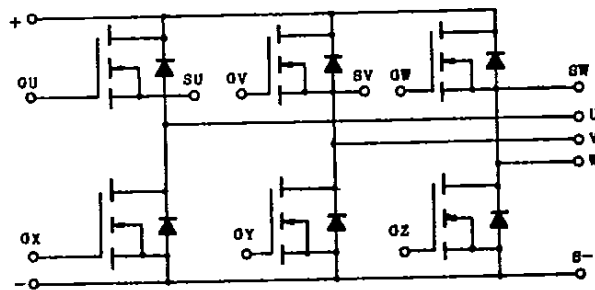
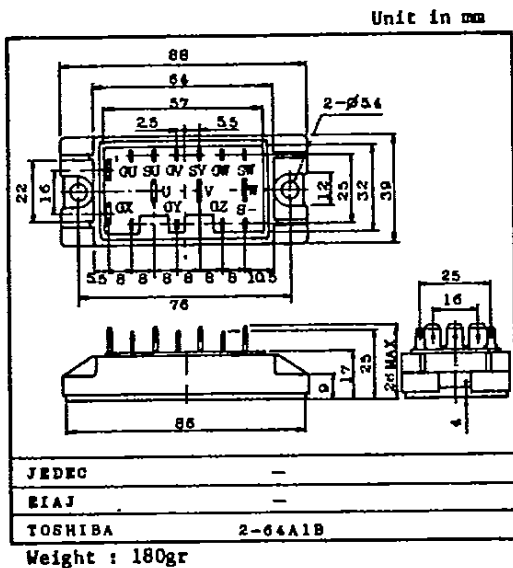
MG15G1AM1



MG15G4GM1



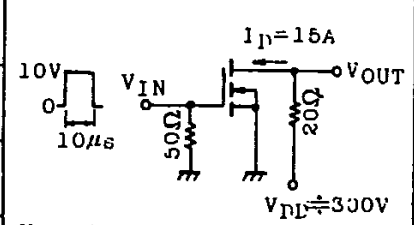
MG15G6EM1



MAXIMUM RATINGS (Ta=25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT
Drain-Source Voltage		V _{DSS}	450	V
Gate-Source Voltage		V _{GSS}	±20	V
Drain Current	DC	I _D	±15	A
	Peak		±30	
Drain Power Dissipation (Tc=25°C)		P _D	125	W
Channel Temperature		T _{ch}	150	°C
Storage Temperature Range		T _{stg}	-40 ~ 125	°C
Isolation Voltage		V _{Isol}	2500 (AC 1 Minute)	V
Screw Torque		-	30	kg·cm

ELECTRICAL CHARACTERISTICS (Ta=25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		I _{GSS}	V _G =±20V, V _D =0	-	-	±100	nA
Drain Cut-off Current		I _{DSS}	V _D =450V, V _G =0	-	-	1.0	mA
Drain-Source Breakdown Voltage		V(BR) _{DSS}	I _D =10mA, V _G =0	450	-	-	V
Gate Threshold Voltage		V _{th}	V _D =10V, I _D =1mA	1.5	-	3.5	V
Forward Transfer Admittance		Y _{fs}	V _D =10V, I _D =15A	4.0	7.0	-	S
Drain-Source ON Resistance		R _{DS(ON)}	I _D =15A, V _G =10V	-	-	0.4	Ω
Source Drain Forward Voltage		V _{SDF}	I _D =-15A, V _G =0	-	-	1.8	V
Input Capacitance		C _{iss}	V _D =10V, V _G =0, f=1MHz	-	4500	-	pF
Switching Time	Rise Time	t _r	 <p> $I_D = 15A$ $V_{IN}: t_r, t_f < 5\mu s$ $D.C. \leq 1\%$ ($I_{OUT} = 50\Omega$) $V_{DL} = 300V$ </p>	-	250	500	ns
	Turn-on Time	t _{on}		-	300	600	ns
	Fall Time	t _f		-	250	500	ns
	Turn-off Time	t _{off}		-	1000	2000	ns
Reverse Recovery Time		t _{rr}	I _D =-15A, R _G =220Ω V _G =-15V, di/dt=60A/μs	-	300	600	ns



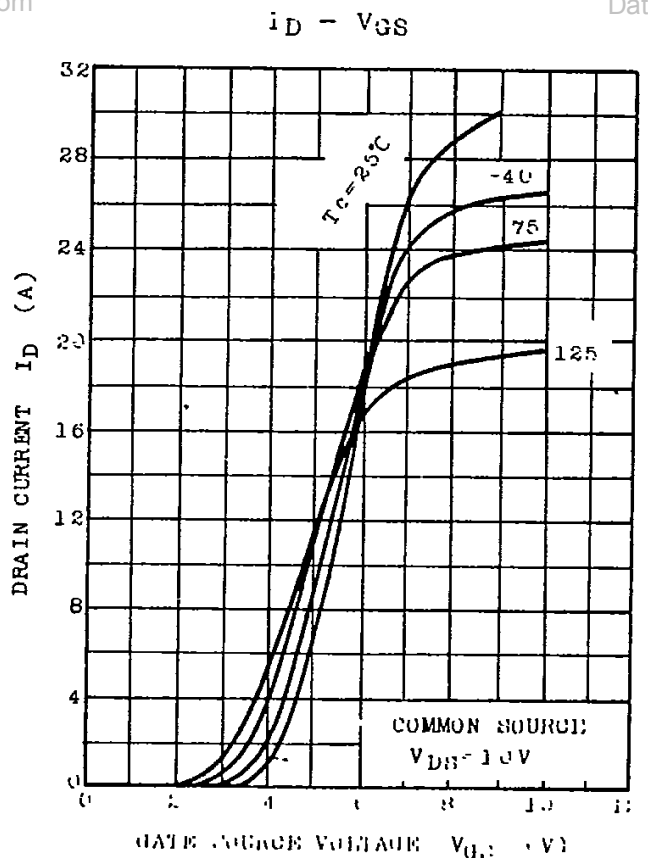
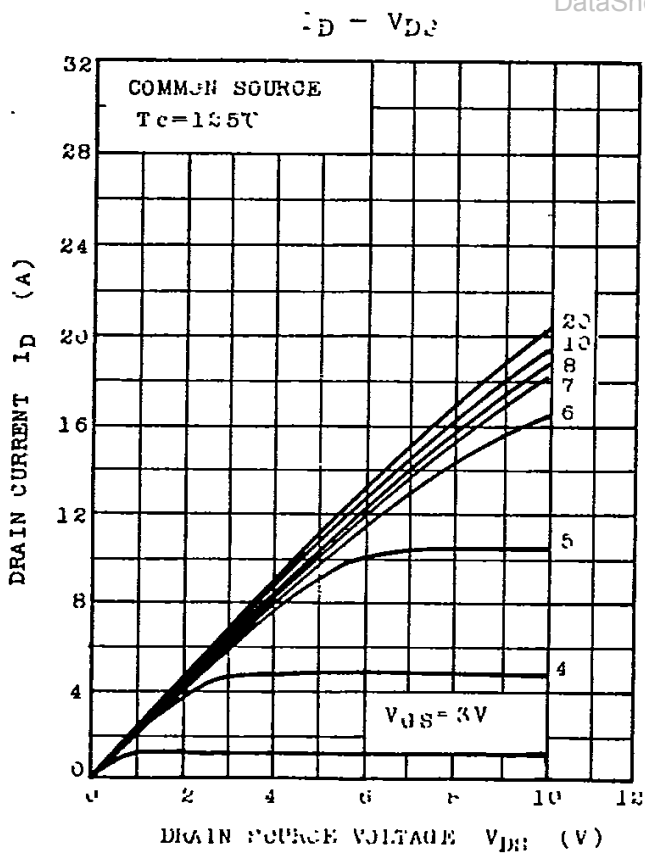
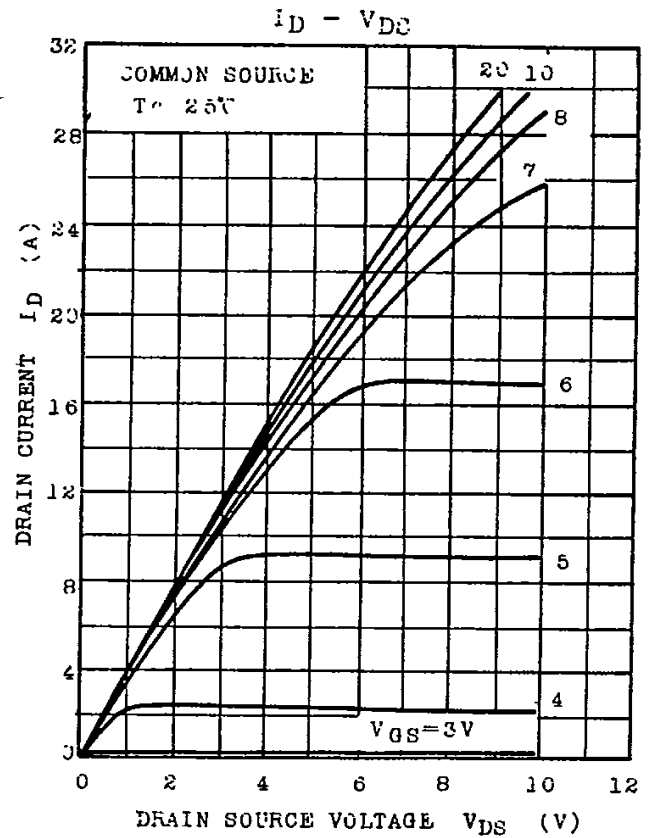
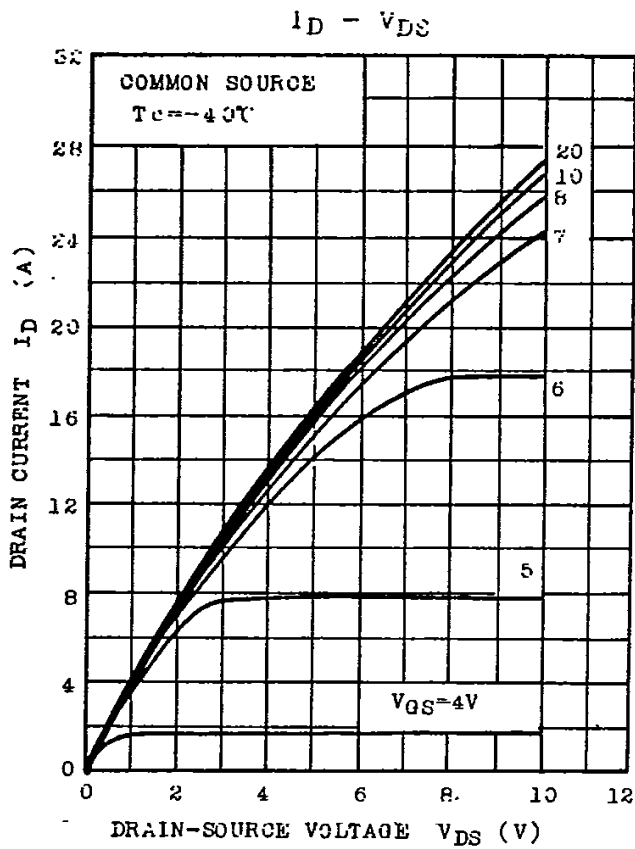
SEMICONDUCTOR

TECHNICAL DATA

MG15G1AM1

MG15G4GM1

MG15G6EM1





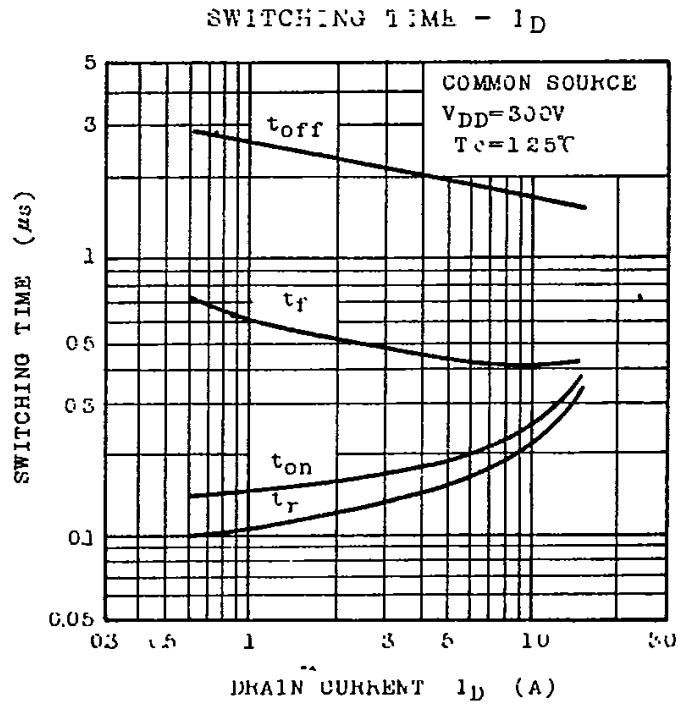
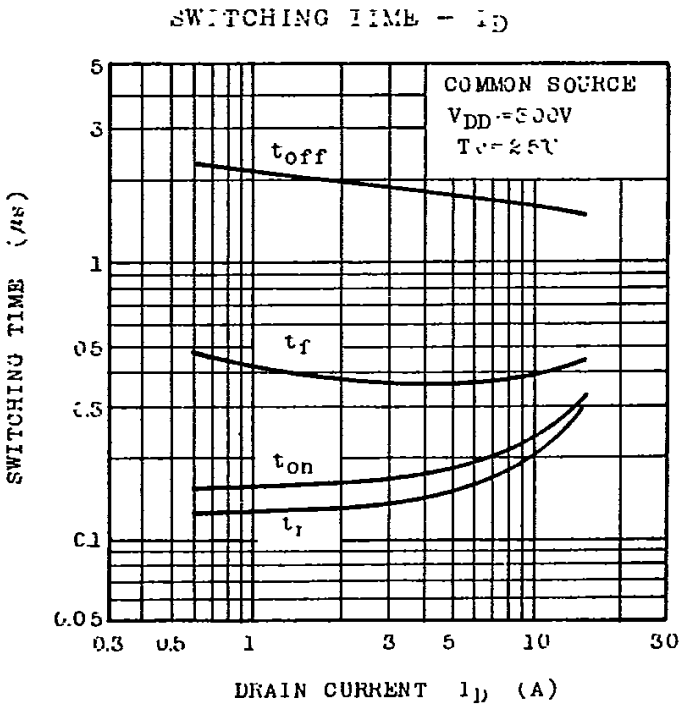
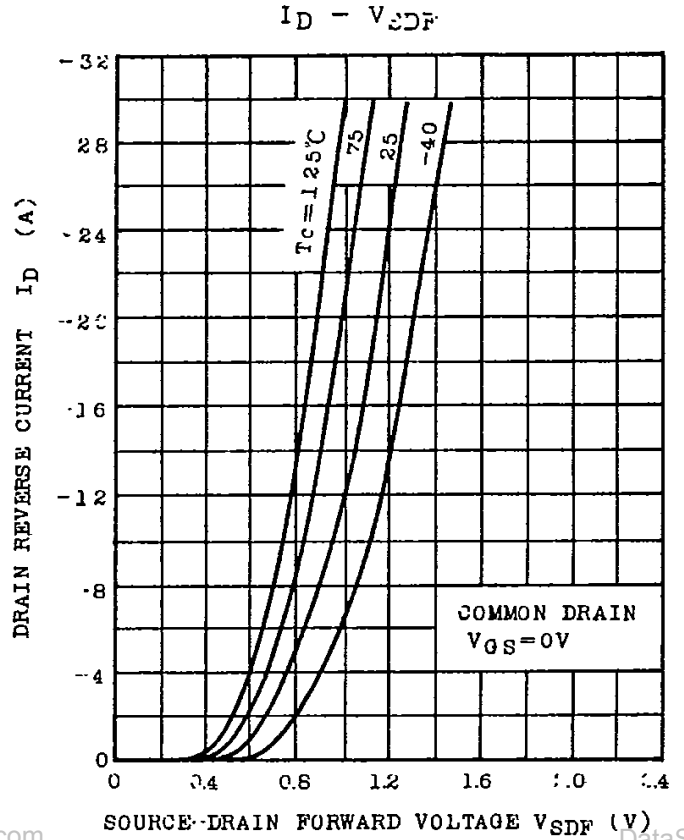
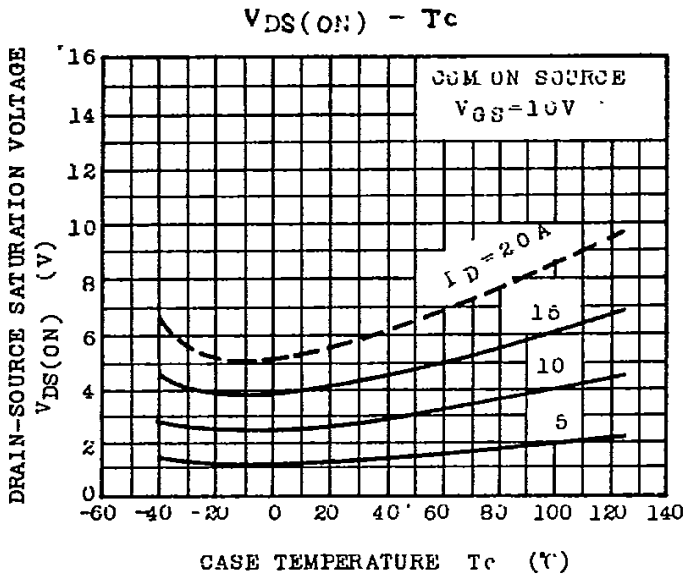
SEMICONDUCTOR

TECHNICAL DATA

MG15G1AM1

MG15G4GM1

MG15G6EM1



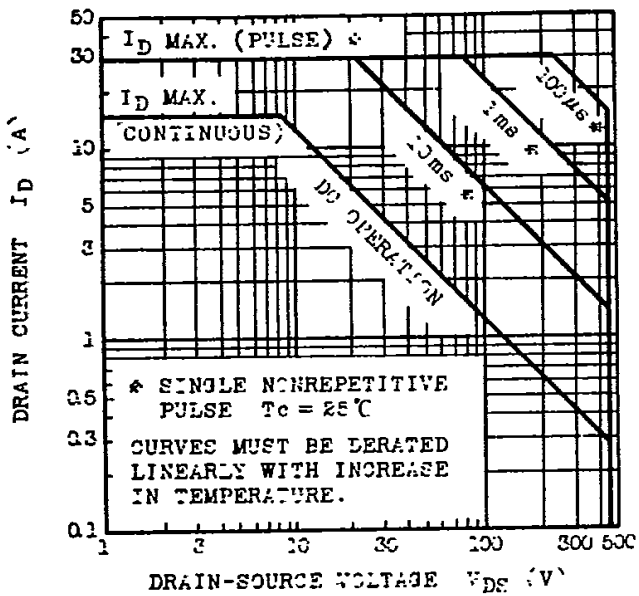


SEMICONDUCTOR

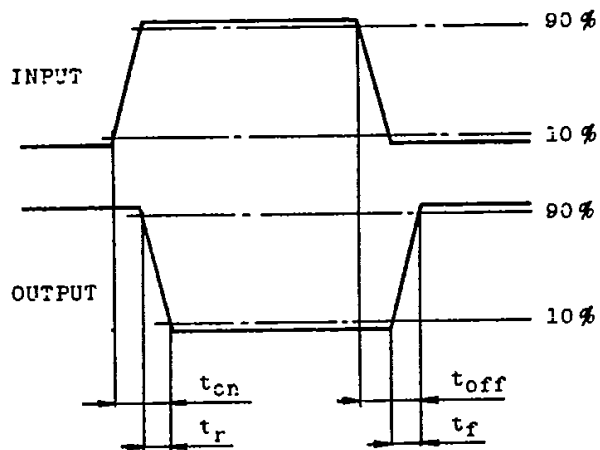
TECHNICAL DATA

MG15G1AM1
MG15G4GM1
MG15G6EM1

SAFE OPERATING AREA



SWITCHING TIME TEST (WAVEFORM)

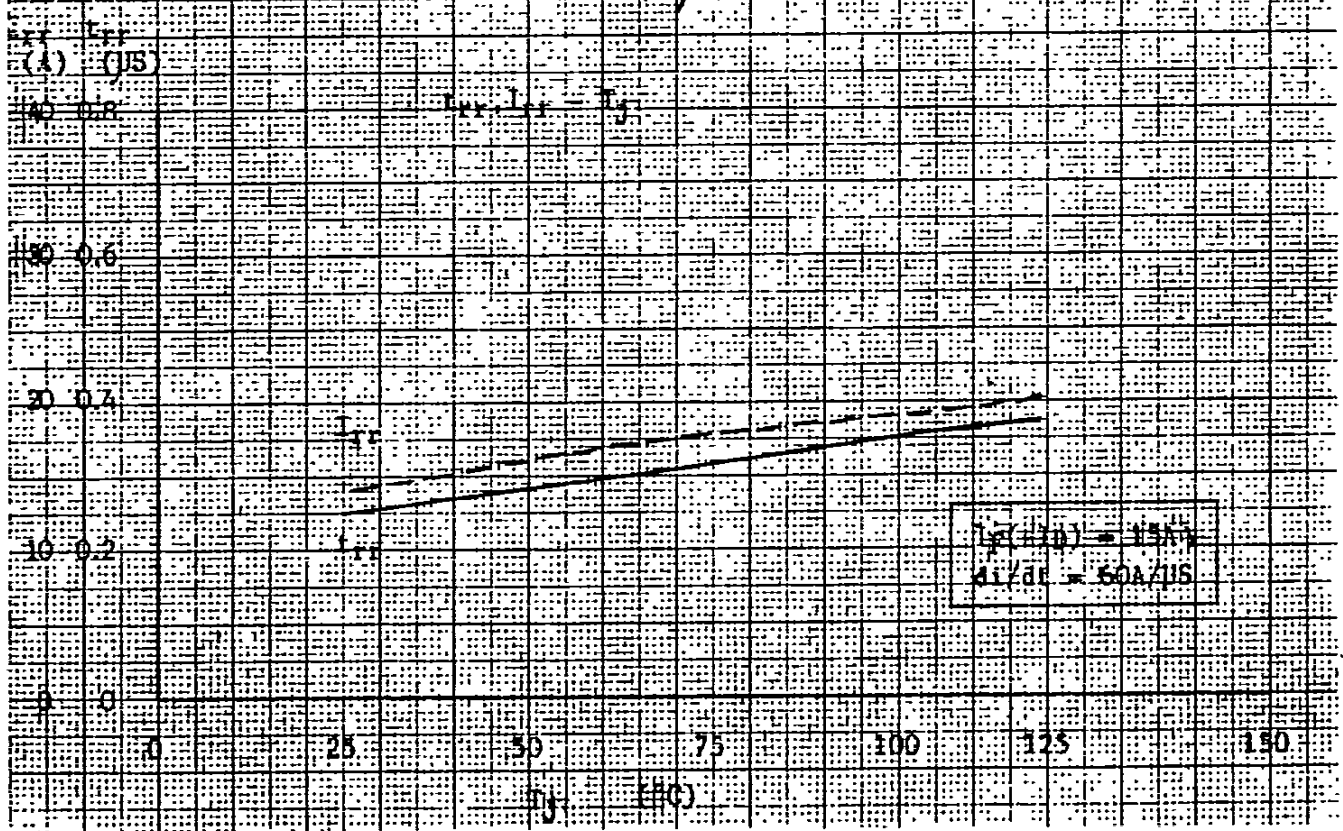
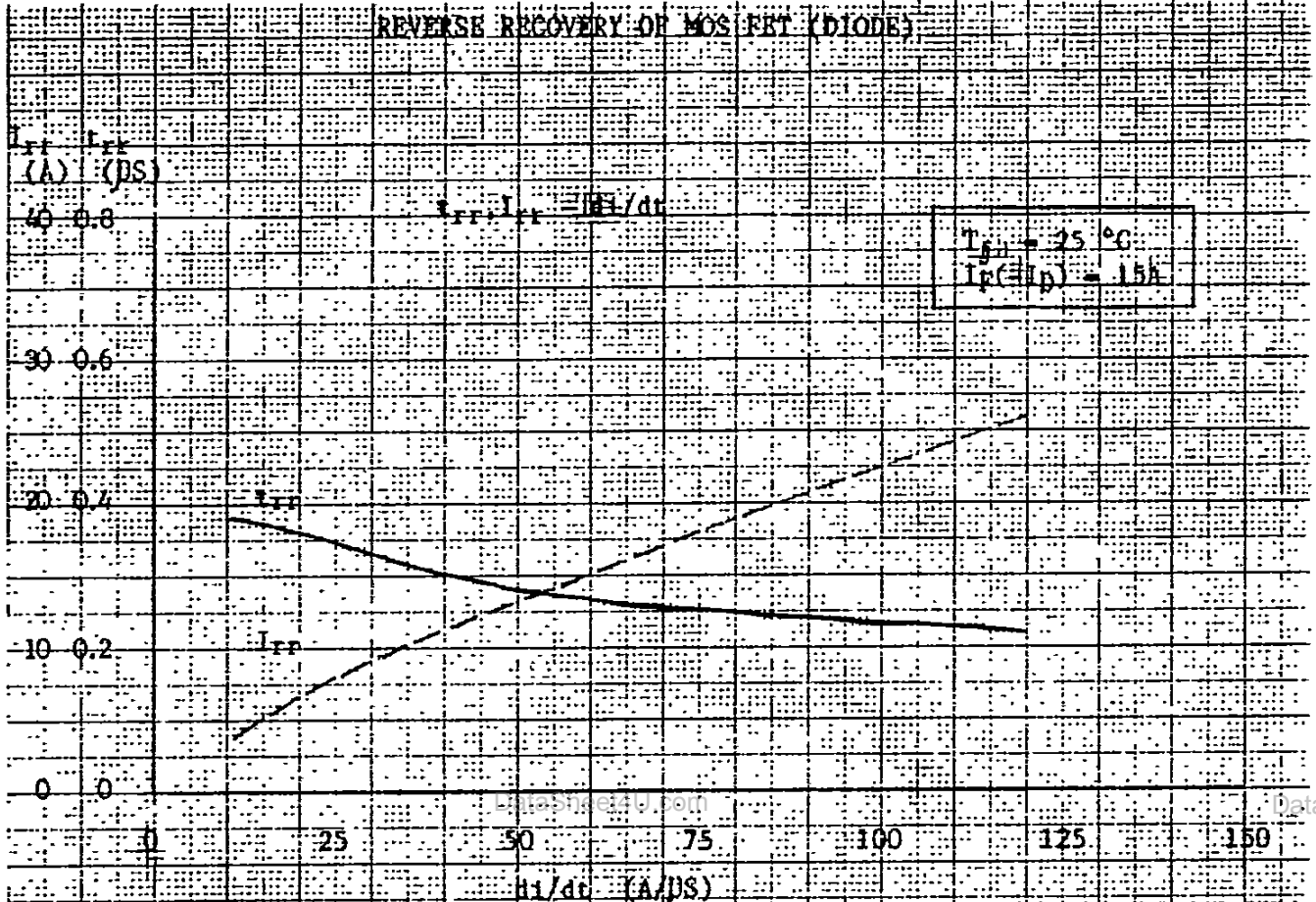




SEMICONDUCTOR TECHNICAL DATA

MG15G1AM1
MG15G4GM1
MG15G6EM1

REVERSE RECOVERY OF MOS FET (DIODE)



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DataShee

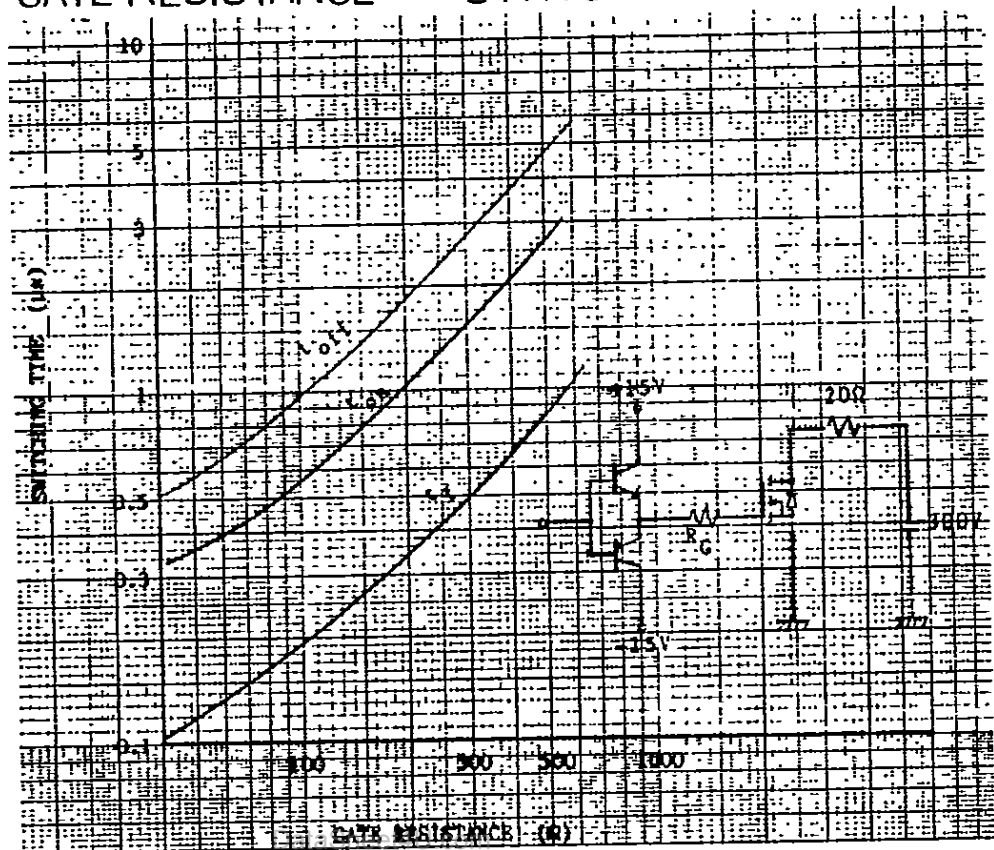


SEMICONDUCTOR

TECHNICAL DATA

MG15G1AM1
MG15G4GM1
MG15G6EM1

GATE RESISTANCE — SWITCHING TIME



REVERSE BIAS — dv/dt CURRENT

